In uence of external factors on dielectric perm ittivity of Rochelle salt: hum idity, annealing, stresses, electric eld

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A bstract

The present work contains results of experimental investigation of external factors, such as dessicating/wetting, thermalannealing, uniaxial and hydrostatic pressures on dielectric permittivity of Rochelle salt crystals. The obtained results are compared with available literature data. A conslusion is made that the dispersion of experimental data can be attributed to internal polar point defects in crystals and to in uence of storage conditions. The obtained results are analyzed within the phenomenological Landau approach.

1 Introduction

An important information about the transition mechanism in ferroelectric crystals can be given by exploring their behavior under in uence of various external factors, such as high pressure or electric eld. For hydrogen bonded crystals the external pressures are the only way to continuously vary geometric parameters of bonds, break their equivalence, etc, which permits to investigate role of hydrogen bonds and their parameters and symmetry in mechanisms of the phase transition and dielectric response of the crystals. Many of ferroelectrics are piezoelectric in the paraelectric phase; application of shear stresses and the conjugate electric elds provides a possibility to explore the role of piezoelectric interactions in the phase transitions and in formation of the physical characteristics of the crystals.

The above mentioned possibilities were fully used for investigation of the KH₂PO₄ family crystals. Theoretical description of pressure and elde ects in these crystals are usually performed within the proton ordering model (see e.g. [1,2,3,4,5,6] and references therein) and a quantitative agreement with experiment is obtained. It was shown, in particular, that pressures of dierent symmetries can produce qualitatively dierent changes in the phase transition: lower its temperature down (hydrostatic), raise it up and smear out the transition (as shear stress $_{6}$), induce a new phase of monoclinic symmetry (as $_{1}$ $_{2}$).

In contrast to the KH $_2$ PO $_4$ fam ily crystals, the data for external factors in uence on Rochelle salt crystals are less extensive. In literature, only a few papers are available on hydrostatic pressure [7, 8, 9] and electric eld [11, 10, 12] e ects on the dielectric perm ittivity of the crystals. Uniaxial stresses e ects on the phase transitions in Rochelle salt were explored in in [13] from the measurements of therm oelastic e ect. Theoretically in uence of the shear stress $_4$ was studied in [14] within the modi ed M itsuim odel.

U sually, peculiarities of the physical characteristics of ferroelectric crystals in the vicinity of the phase transitions (especially of the second order ones) are a ected by crystal defects and internal bias electric elds and mechanical stresses, which act as the external ones. The role of such factors, as crystal defectness and the processes in the sam ple prehistory, that may a ect the physical properties of the crystals via relaxation of the defects: thermal annealing, previous in uence of electromagnetic elds and mechanical stresses, must be explored. High pressure and electric eld studies allow to explore the intrinsic eld and pressure dependences of the crystal properties, reveal the internal bias elds and stresses, and study the residual elects of the internal defects.

For Rochelle salt, whose chem ical instability (loss of crystallization water at slightly elevated tem peratures) and water absorbency are well known, other factors such as air hum idity, storage conditions, etc are important and should be monitored during measurements. For instance, a signicant dispersion of experimental data for the dielectric permittivity of Rochelle salt (see the system atization in [15]), exceeding the measurement error, takes place. Apparently, the dispersion is due to the dierent internal states of the samples, not controlled during measurements.

In the present work the results of experimental studies of the mentioned above external factors (pressure, electric eld, humidity, them alannealing) in uence on dielectric permittivity of Rochelle salt crystals in the vicinity of the structural phase transitions are reported.

2 Experim ental setup

D ielectric perm ittivity of the crystals $"_{11}$ was determ ined by m easuring the sam ples capacity with the help of an a.c. bridge at xed frequency of 1 kH z. M easurem enterror was 0.2 - 0.4%.

Sam ples were prepared in a form of parallellepipeds, with faces perpendicular to crystallographic axes of an orthorhom bic (paraelectric) unit cell. Silver paste and copper wires, 0:08 0:12 mm diameter, were used as electric contacts. A fler partial drying of the paste, the contacts were covered by an alcohol solution of a glue with addition of silver paste. This method provided a necessary mechanical stability of the contacts and allowed a free deformation of the crystals.

A uniaxial pressure was created by a spring dynam om eter and transm itted to samples via a punch with oating heads, thus securing a uniform pressure even at possibly non-parallel faces of the sample. The pressure was xed with an accuracy of 5%. The samples were placed in a therm ostate, allowing smooth adjustment of temperature. Temperature was measured by a copper-constant an therm occupie with an accuracy 0:1. Samples with the therm occupie were covered with silicone oil, in order to enhance heat transmission and prevent direct contact with air.

3 Modelapproach

Theoretical description of the physical properties of Rochelle salt is usually performed within a two-sublattice Ising model with asymmetry double well potential (Mitsuimodel). Below we present the expression for the dielectric permittivity of Rochelle salt obtained within the modied Mitsuimodel with taking into account the piezoelectric coupling [15] with the Hamiltonian

$$\begin{split} \hat{H} &= \frac{N}{2} v c_{44}^{E_0} \mathbf{u}_4^2 & \text{N } v e_{14}^0 \mathbf{u}_4^2 E_1 & \frac{N}{2} v \cdot \frac{0}{11} E_1^2 & \frac{1}{2} \frac{X}{qq^0} \cdot \frac{X^2}{f f^0 = 1} R_{qq^0} \cdot (f f^0) - \frac{qf}{2} \cdot \frac{q^0 f^0}{2} \\ & X & \qquad \qquad X & X^2 & \qquad \qquad X & X^2 & \qquad \qquad X^2 & \qquad \qquad X^2 & \qquad \qquad X^2 & \qquad \qquad Y^2 & \qquad Y^2$$

Three rst terms in (3.1) correspond to a 'seed" energy of the crystal lattice which forms the asymmetric double well potential for the pseudospins. R_{qq^0} (11) = R_{qq^0} (22) = J_{qq^0} and R_{qq^0} (12) = R_{qq^0} (21) = R_{qq^0} are constants of interaction between pseudospins belonging to the same and to dierent sublattices, respectively. The parameter describes the asymmetry of the double well potential; I_{qq^0} is the elective dipole moment. The last term is the internal eld created by the piezoelectric coupling with the shear strain " I_{qq^0} .

W ithin a mean eld approximation the static dielectric permittivity of a free crystal is obtained in the form [15]

$$_{11} = _{11}^{0} + \frac{(_{1}^{0})^{2}}{2v} F_{2}(0);$$
 (3.1)

where , are the parameters of ferroelectric and antiferroelectric ordering. The following notations are used

$$F_{2}(0) = \frac{7}{72} \frac{3}{3};$$

$$Y_{2} = 1 \quad \frac{J}{2} \quad 1 \quad \frac{2K^{2}J^{2}}{16} \left(\begin{array}{ccccc} 2 & 2 \\ 1 & 2 \end{array}\right); \quad Y_{3} = \quad 1 + \quad \frac{KJ}{4} \left(\begin{array}{ccccc} 2 & 2 \\ 1 & 2 \end{array}\right); \quad = \quad \frac{2\frac{2}{4}}{VC_{44}^{E0}};$$

$$I_{1} = 1 \quad 2 \quad 2; \quad 2 = 2 \quad ;$$

$$C_{14}^{0} = \frac{e_{14}^{0}}{C_{44}^{E0}}; \quad C_{44}^{0} = \frac{e_{14}^{0}}{11} + e_{14}^{0} d_{14}^{0}; \quad C_{14}^{0} = \quad 1 \quad 2 \quad 4d_{14}^{0};$$

Values of the model parameters providing the best to the permittivity are given in Table 1.

Table 1: Model parameters for Rochelle salt [15].

J=k _B	$K = k_B$	$K = k_B$ $= k_B$ $_4 = k_B$				$c_{44}^{E\ 0}$ d_{14}^{0}		
	K				am^2	esu,	/dyn	
797.36	1468.83	737.33	- 760	12 : 8	1^{0}	1:9	10 ⁸	0.363

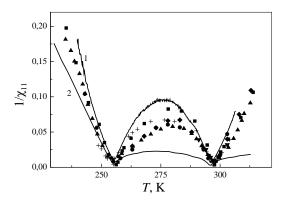
 $v = 0.5219 [1 + 0.00013 (T 190)] 10^{21} cm^{3}$

4 In uence of sample prehistory on dielectric permittivity of Rochelle salt

4.1 Hum idity

In [17] it was found that crystals of Rochelle salt at 25 and relative hum idity below 40% lose the crystallization water, whereas at relative hum idity above 85% they absorb water from air. Experimentally, signicant changes of the piezoelectric properties of Rochelle salt were observed, when samples are kept in air with high concentration of ethanol vapor [16].

Experim ental data for the susceptibility of Rochelle salt of dierent sources (see g.1) show an essential dispersion, even in the paraelectric phases, which cannot be accounted for by the changes in the measurements regimes. Of interest was thus to explore the temperature dependences of Rochelle salt crystals with dierent water content, in order to verify whether this dispersion can be attributed, at least partially, to it.



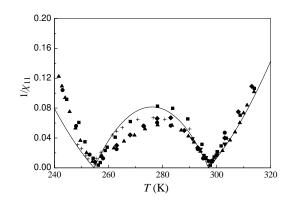


Figure 1: Tem perature dependences of inverse susceptibility of Rochelle salt. Left: solid lines { experimental data, this work, obtained for 1 { dessicated sample; 2 { wet sample. Right: solid line { theoretical curve, calculated with (3.1). { [18]; N { [19]; { [20]; + { [23].}

The obtained results are presented in g.1 (left). A part from the literature data, we show here the tem perature dependences of the inverse dielectric susceptibility $\frac{1}{11}$ (solid curves 1 and 2), obtained in this work for the same sample with dierent water content. The curve 1 is obtained for a sample, kept for a long time (2{3 days}) at room temperature in a closed volume, lled with a dessicator (silicagel). The curve 2 corresponds to the same sample, kept for 10 hours in air with relative hum idity 90%. As one can see, keeping the sample in a wet air decreases the dielectric susceptibility in the entire studied temperature range. The changes are particularly prominent in the middle of the ferroelectric phase T 275 K and in the high-temperature paraelectric phase.

Comparison of the obtained results with literature data shows that the dispersion in the values of the susceptibility indeed can be caused by a dierent water content in the samples used in dierent experiments. It should be also noted that for a wet sample (curve 2, g.1), a linear temperature dependence of inverse susceptibility 1 (T) with the Curie-W eiss constant $C_{W}=1.95$ $10\,\mathrm{K}$. For a dessicated sample, the dependence 1 (T) is non-linear in both paraelectric phases.

Comparison of literature experimental data with the theoretical ones, obtained in [15] from the formula (3.1), is given in g.1 (right). Theoretical absolute values of the permittivity are adjusted by the choice of the value of the excitive dipole moment $_1$. In [15] $_1$ was chosen such as the best agreement with the data of [22] as well as of the dynamic microwave permittivity is obtained. On this, we, however, failed to get an adequate agreement with experiment for susceptibility in the low-temperature paraelectric phase [15].

4.2 In uence of them alannealing

Fit. 2 illustrates the tem perature dependences of dielectric perm ittivity of Rochelle salt near the upper Curie point for samples annealed at 308 K.On increasing the annealing time, the value of the dielectric perm ittivity at the transition point increases, and the maximum temperature decreases. Such changes are apparently caused by internal electrical bias elds, which magnitude is decreased with increasing annealing time.

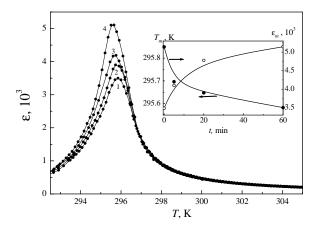


Figure 2: Tem perature dependences of the dielectric perm ittivity of Rochelle salt near the upper transition point at dierent times of annealing in the paraelectric phase at 308 K (m in): 1 { 0, 2 { 5, 3 { 20, 4 { 60. Inset: dependences of the maximal value of perm ittivity and maximum temperature on annealing time.

The internal bias elds are created by polar defects [24], which at long-term keeping sam ples in the ferroelectric phase participate in screening of spontaneous polarization and reject the corresponding domain structure. A ction of the internal bias eld is analogous to the action of external eld, that is, the temperature of the upper maximum of permittivity is increased, and the maximum magnitude is decreased. In the next section we shall estimate the magnitudes of the internal bias elds in the non-annealed and annealed samples.

5 In uence of external electric eld

In g.3 we show the measured temperature dependences of dielectric permittivity " $_{11}$ of Rochelle salt crystals near the upper and lower transition points at dierent values of external d.c. electric eld E = E $_1$ applied along the ferroelectric axis (conjugate to polarization). The insets contain the eld dependences of the dielectric permittivity maxima"_m and their temperatures $T_m = T_m$ (E) T_m (0). The data are obtained by cooling samples for the upper maximum and by heating for the lower one (from the corresponding paraelectric phase towards the ferroelectric phase). As expected, the external eld, conjugate to polarization, decreases the " $_m$ and shifts the maxima temperatures T_m in a non-linear way. For the upper maximum $T_{m,2} > 0$, whereas for the lower one $T_{m,1} < 0$.

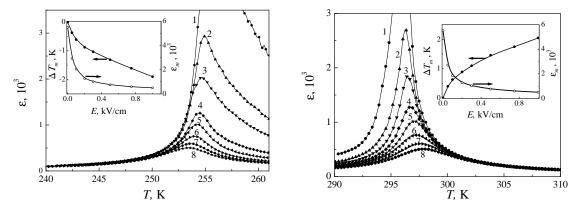


Figure 3: Tem perature dependences of the dielectric perm ittivity of Rochelle salt crystals near upper and lower transition points at dierent values of external electric eld E_1 (kV/cm): 1 { 0, 2 { 0.05, 3 { 0.1, 4 { 0.2, 5 { 0.3, 6 { 0.5, 7 { 0.75, 8 { 1. Lines are guide to the eyes.}}}

These results are compared in g.4 with literature data obtained from the eld dependences of perm ittivity [25] and elastic compliance s_{44}^E [10]. The obtained in this work eld dependences of the perm ittivity maxima magnitudes \mathbf{m}_{n}^{1} are the same for the two maxima (see g.4) and well accord with the data of [25]. However, a perceptible disagreement is observed for the shift of the perm ittivity maxima temperatures. Our data yield very close changes of j T $_{m}$ j with eld for the two maxima. On the contrast, the obtained in [25] eld dependence of the upper maximum temperature is much stronger that of the lower one.

For Rochelle salt the phenom enological Landau expansion of the therm odynam ic potential can be presented as

$$(P_1) = {}_{0} + \frac{1}{2}P_1^2 + \frac{1}{4}P_1^4;$$
 (52)

where P_1 is the crystal polarization, ; are the expansion coe cients. The electric eld E_1 is applied along the axis of spontaneous polarization [100].

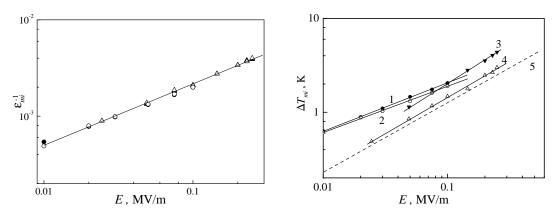


Figure 4: Field dependences of the permittivity maximam agnitudes (left) and temperature shifts (right). Upper maximum: curve 1 and { this work, curve 3 and H { [16], curve 5 { [10]. Lowermaximum { curve 2 and } { this work, curve 4 and M { [16].

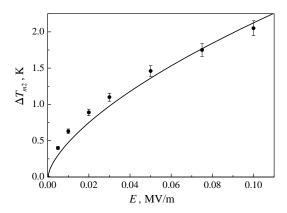


Figure 5: Field dependence of the upper perm ittivity maximum temperature shift. Line is calculated with (5.4). Symbols are experimental data of this work.

For Rochelle salt there are two possible ways to model the temperature dependence of the coe cient.

1) The expansion (5.2) is performed near each of the two transitions separately, assuming a linear temperature dependence = $_{T\,1}$ ($T_{C\,1}$ T) for the lower transition and = $_{T\,2}$ ($T_{C\,2}$) for the upper one. Then the eld dependences of T_m (T_m) and T_m (T_m) can be presented as

$$\mathbf{u}_{m}^{1} = \frac{3}{2} \frac{(4)^{1=3}}{4} \mathbf{u}_{0} E_{1}^{2=3} = k_{1} E_{1}^{2=3} :$$
 (5.3)

$$j T_{m i} j = \frac{3}{4} \frac{(4)^{1-3}}{T_{i}} E_{1}^{2-3} = k_{2} E_{1}^{2-3}; \quad i = 1; 2$$
 (5.4)

2) Within the second approach, the coe cent is chosen in the form

$$= _{1} + _{2} (T T_{0})^{2}; (5.5)$$

where $T_0 = \frac{T_{C1} + T_{C2}}{2}$, and $T_{C1;2} = T_0$ $\frac{-1}{2}$. Such a choice is validated by the fact that the phase transitions in R ochelle salt are closed to a double critical point [26, 10], realized at partial substitution of potassium atom s with ammonia NH $_4$ [27, 11]. In [26, 10] the temperature dependences of several physical characteristics of R ochelle salt were successfully described within the Landau approach with (5.5).

In this case, the eld dependences of T_m (E₁) are

$$T_{m 1;2} = A = \frac{3}{4} \frac{(4)^{1=3}}{(4)^{1=3}} E_1^{2=3} + A^2;$$
 (5.6)

where $A^2 = {}_{1}= {}_{2}$. The eld dependence of ${}^{"}_{m}$ (E₁) in this case is the same as in the 1rst approach and described by (5.3).

The experimental dependences of $^{"}_{m}^{1}$ (E₁) of this work are well described by equation (5.3) with $k_1 = 10.2 \quad 10^7$ (m/V) $^{2=3}$ and $= 11.34 \quad 10^3$ V m /C 3 . Fitting to the experimental data for T m (E₁) with eq. (5.4), shown in Fig. slivka6c, yields the values of k_2 and $^{T}_{11}$, $^{T}_{2}$ for the upper and lower maxima:

for
$$T_{C1}$$
: $k_2 = 9:9$ 10^4 (m =V)²⁼³ and $T_{11} = 5:82$ $1\overline{0}$ V m (K \overline{C})
for T_{C2} : $k_2 = 10:5$ 10^4 (m =V)²⁼³ and $T_{12} = 5:49$ $1\overline{0}$ V m (K \overline{C})

A green ent with experiment for T_m (E₁), obtained with formulas (5.6) is not any better than with (5.4). We found that

$$_{1} = 5.82 ext{ 10 V m }$$
 $^{\circ}$ $_{2} = 1.32 ext{ 10 V m }$ $^{\circ}$ $^{\circ}$.

A dvantages of this approach are visible only at description of the physical characteristics of Rochelle salt in a su ciently wide temperature range in the paraelectric phases, where the non-linear temperature dependence of the inverse permittivity should be essential. However, for description of the eld dependences of T_m (E₁) the non-linearity of the coe cient within a few Kelvins near the transition points does not play any signicant role.

Description of the eld dependences of the dielectric perm ittivity of Rochelle salt within a modi ed M itsui model with piezoe ect will be given in another publication.

U sing the above results, we can estim ate the magnitude of internal bias elds, existing in crystals without annealing and after 60 m in of annealing. In the form er and latter cases, the values of the permittivity at the upper transition point are about 3500 and 5100 (see g.2). Therefore, using (5.3) and the found values of k_2 , we get that at the upper Curie point E $_{\rm bias}$ = 0.055 kV/cm for a non-annealed sample and E $_{\rm bias}$ = 0.027 kV/cm for the sample annealed for 60 m in.

6 External pressures

6.1 Uniaxial stresses

The tem perature dependences of dielectric perm ittivity $"_{11}$ of Rochelle salt were measured at 1 kH z and dierent values of mechanical stresses applied along the main crystallographic directions of unit cell: [100] { $_1$, [010] { $_2$, [001] { $_3$ and along [011] { $_4$. In the reference system with axes along the main crystallographic directions, the stress \sim_4 can be presented as

$$\sim_4 = {}_4 + \frac{1}{2} \left({}_2 + {}_3 \right); \tag{6.1}$$

where $_4$ is the shear strain, which for the Rochelle salt symmetry is the external eld conjugate to the order parameter and acts similarly to the electric eld E_1 .

Figs. 6-9 contain the obtained tem perature dependences of dielectric perm ittivities at dierent values of the uniaxial pressures and the corresponding stress dependences of the perm ittivity maxima temperatures. The data, as in the case of electricely eld study, were obtained at cooling for the upper maximum and at heating for the lower maximum (on going from the corresponding paraelectric phase towards the ferroelectric phase).

Sim ilarly to the electric eld E_1 , all explored uniaxial stresses decrease the maximal values of the dielectric perm ittivity and change their temperatures $T_{m\,1}$ and $T_{m\,2}$. Action of the stresses $_1$ and $_4$ on $T_{m\,1}$ and $T_{m\,2}$ is non-linear and similar to the action of the electric eld E_1 : $dT_{m\,1}=d_i<0$; $dT_{m\,2}=d_i>0$ (i=1 and 4). It should be noted that the change of the upper maximum temperature with the stress $_4$ is much larger than of the lower maximum. Let us remain that the obtained in this work changes of the maxima temperatures with the electric eld E_1 are almost the same for the two maxima (see gs. 4, 5).

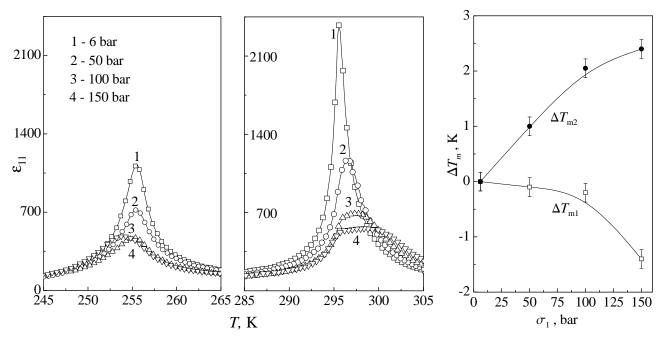


Figure 6: Tem perature dependences of the dielectric perm ittivities of Rochelle salt at dierent values of m e-chanical stress $_1$ and the stress dependences of the perm ittivity m axim a tem peratures.

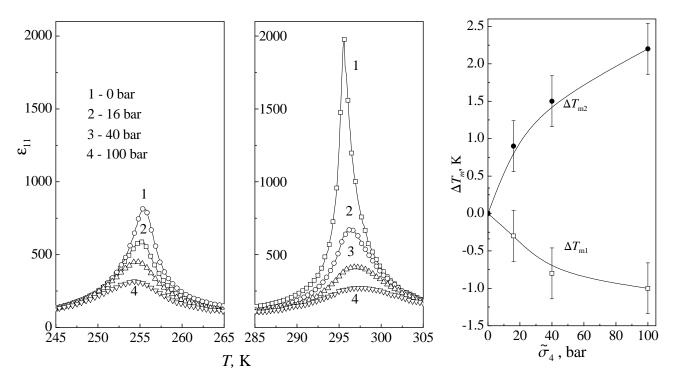
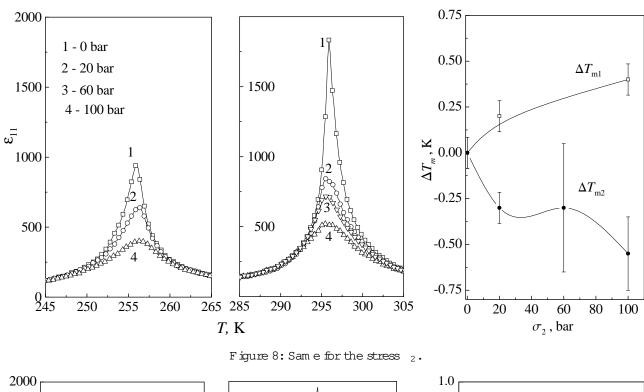


Figure 7: Sam e for the stress \sim_4 .



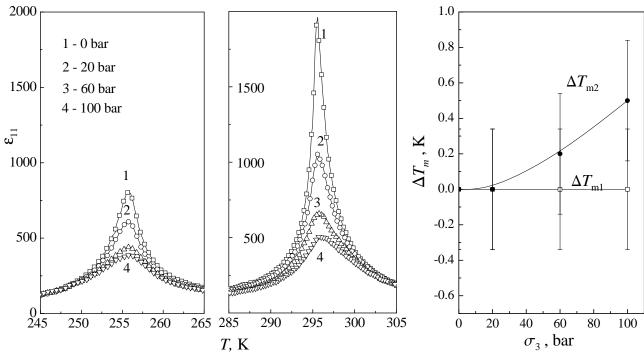


Figure 9: Sam e for the stress $_3$.

The experim ental data for the shifts of the transition temperature with the uniaxial stresses (per 100 bar) are system ized in Table 3. For comparison, we present here the corresponding literature data obtained in [13] on the basis of therm collastice ect. O verall, the obtained in this work data qualitatively agree with the literature data, except for the case of stress $_3$. However, the quantitative agreement is rather poor, our data for j T $_{\rm C}$ ij being a few times smaller.

6.2 Hydrostatic pressure

Fig. 10 contains the temperature dependences of the dielectric perm ittivity of Rochelle salt at dierent hydrostatic pressures. In contrast to electric eld or uniaxial stresses, the hydrostatic pressure increases both transition temperatures (see the inset with the p;T-diagram). The pressure coe cients of the transition temperatures are $dT_{\text{Cl}} = dp = 3.54 \text{ K/kbar}$ and $dT_{\text{Cl}} = dp = 10.92 \text{ K/kbar}$, in a perfect agreement with the data of [7, 8]. On increasing the hydrostatic pressure, the value of \textbf{m}_{m} at the lower transition point T_{Cl} monotonously decreases and remains unchanged at T_{Cl} .

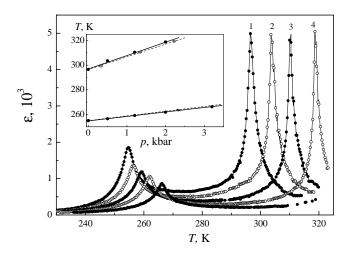


Figure 10: Tem perature dependence of the dielectric perm ittivity of Rochelle salt at dierent values of hydrostatic pressure p, M Pa: 1 { 0; 2 { 50; 3 { 120; 4 { 200; 5 { 320. Inset: the p; T phase diagram. Dashed lines and { data of [7].

6.3 Phenom enological description of pressure e ects

For phenom enological description of external pressure in uence on the phase transitions in Rochelle salt, let us m odify the expansion (5.2) in the following way

$$(P_{1}; i) = {}_{0} + \frac{1}{2}P_{1}^{2} + \frac{1}{4}P_{1}^{4} + \sum_{i=1}^{X^{3}} q_{i1} iP_{1}^{2} + q_{14}P_{14} \frac{1}{2}\sum_{ij=1}^{X^{4}} s_{ij}^{P} i j$$

$$(6.2)$$

(for the sake of sim plicity we changed here the signs the stresses $_{i}$, in comparison with the standard notations, so that the uniaxial compression stresses are positive, and for the hydrostatic pressure we have $p=_{1}=_{2}=_{3}$. In standard notations $p=_{1}=_{2}=_{3}$ and values of the compression stress are negative.) The quantities q_{i1} have a meaning of electrostriction coecients, s_{ij}^{p} are the elastic compliances at constant polarization. Let us note that s_{ij}^{p} for i=1;2;3 and s_{44}^{p} are practically temperature independent, whereas $s_{i4}^{p}=_{1}$, that is, they are different from zero only in the ferroelectric phase or in presence of electric eld (possibly internal bias eld E_{bias} due to polar defects) or stress $_{4}$.

From (6.2) the equations for polarization and lattice strains follow

$$E_{1} = g_{14} + (+ 2 \qquad g_{i1}) P_{1} + P_{1}^{3} \qquad \frac{X^{3}}{P_{1}} \qquad \frac{g_{i4}^{P}}{P_{1}}$$

$$= 1 \qquad (6.3)$$

$$u_{i} = \frac{\varrho}{\varrho_{i}} = \sum_{j=1}^{X^{4}} s_{ij}^{P} + q_{i1}P_{1}^{2}; \quad i = 1;2;3$$
 (6.4)

$$u_4 = g_{14}P_1$$
 S_{ij}^P
 $j=1$
(6.5)

Assuming a linear dependence of the coe cient = $_{T1}(T_{C1} T)$ for the lower transition and = $_{T2}(T T_{C2})$ for the upper one, we get for the transition temperatures shift and the inverse values of the permittivity of a free crystal (at constant stress)

$$T_{C1;2} = \frac{2}{T_{1;2}} \sum_{i=1}^{X^3} q_{i1\ i} \quad k_1 (E_{bias} \quad g_{14\ 4})^{2=3}$$
 (6.6)

$$\mathbf{w}_{\text{m 1};2}^{1} = \mathbf{k}_{2} \times \mathbf{E}_{\text{bias}} \quad \mathbf{g}_{14} \quad \mathbf{g}_{14} + \frac{\mathbf{X}^{3}}{\mathbf{p}_{1}} \frac{\mathbf{s}_{\underline{i}4}^{p}}{\mathbf{p}_{1}} \quad \mathbf{i}_{4})^{2=3}$$
: (6.7)

Experim ental data for g_{14} are rather dispersive (see the system atization in [15]). We used here the theoretical data for g_{14} of [15], agreeing overall with experiment. The electrostriction coecients have been determined in [28]. We use adjusted here their values, in order to get a good to the hydrostatic pressure dependences of transition temperatures. The used values of q_{i1} , q_{14} at lower and upper transition points are given in table 2.

Table 2: The used data for q_{i1} (in m $^4/C^2$) and g_{14} (in m $^2/C$).

	q_{11}	q_{21}	q_{31}	9 14
T _{C 1}	-7.5	4	4.5	0:174
$T_{\text{C 2}}$	-10	4.3	2.5	0:195

We consider rst the case of a perfect crystal (E $_{\rm bias}$ = 0). The calculated shifts of the transition tem peratures (perm ittivity maxima tem peratures) with uniaxial and hydrostatic pressures are presented in table 3. As one can see, a very good agreement is obtained with the hydrostatic pressure data, as well as the data of [13] for the uniaxial stresses. A greement with the calculation data for \sim_4 is completely unsatisfactory. Here we used an assumption that, according to (6.1), \sim_4 = 100 bar corresponds to a sum of $_4$ = 50 bar, $_2$ = 50 bar, $_3$ = 50 bar. Our data for the uniaxial stresses are also in a poor agreement with the phenomenology and with the literature data; however, the data calculations and of [13] agree fairly well.

Table 3: Shifts of the transition temperatures with uniaxial stresses (per 100 bar) and with hydrostatic pressure (per 1 kbar).

	1		2		3			~4		hydrostatic			
	exp.	[13]	calc.	exp.	[13]	calc.	exp.	[13]	calc.	exp.	calc.	exp.	calc.
												3.43	
$T_{\text{C 2}}$	2.0	3.5	3.44	-0.6	-1. 6	-1.4 8	0.5	-0.8	-0.86	2.2	9.1	10.92	10.99

It seems likely that the disagreement between the experimental data of this work and of [13] should be attributed to the in uence of sample defects. We recalculated the shifts of the maxima temperature with uniaxial pressure with taking into account also the role of internal biaseld, determining them from (6.7). A much better agreement was obtained for the stresses $_2$ and $_3$: j T $_{\rm C}$ ijdecrease by several times with increasing E $_{\rm bias}$ = 0. However, for the stress $_1$, the presence of the biaseld has further enhanced the theoretical values j T $_{\rm C}$ ij only worsening an agreement with the experimental data of this work. At the moment, we have no complete explanation of the disagreement between our experimental data and the data of [13] and of the calculations, especially in a view of the fact that for the hydrostatic pressure a complete coincidence with the literature data and with phenomenology is obtained.

The reasons for the strong decrease of perm ittivity maxima magnitude with diagonal stresses $_{i}$, i = 1;2;3 is not quite clear either. As follows from (6.7), such a decrease can be accounted for by the increase of the internal bias eld E $_{bias}$ or of the coe cient k $_{2}^{p}$ $_{i=1}^{1=3}$. Such an increase of k_{2} can be obtained if we take into account the terms of the fourth order of the $_{i=1}^{3}$ $_{i=1}^{(4)}$ $_{i}^{9}$ $_{i}^{1}$ $_{i}^{1}$ $_{i}^{9}$ $_{i}^{1}$ type in the expansion (6.2). E ectively it would lead to renorm alization of the coe cient $_{i=1}^{9}$ $_{i=1}^{9}$ $_{i=1}^{3}$ $_{i=1}^{4}$ $_{i}^{4}$ $_{i=1}^{9}$ $_{i=1}^{4}$ $_{i=1}^{9}$ $_{i=1}^{9$

7 Conclusions

- Strong dependence of the dielectric perm ittivity of Rochelle salt on hum idity of the storage air is shown. We believe that the dispersion of experimental data of dierent literature sources can be caused by uncontrolled water content during and previously to the measurements.
- Dependence of the perm ittivity value at the transition points on duration of them alannealing in hightem perature paraelectric phase indicate the existence of internal electric bias elds in the crystals due to point polar defects.
- In uence of external electric eld, uniaxial stresses, and hydrostatic pressure on the dielectric perm ittivity is studied. The results are compared with available literature data. Analysis of the obtained results is performed within the phenomenological Landau approach. Possible reasons for discrepancies in the data are discussed.

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